

CONTROLLED AVALANCHE RECTIFIER DIODES

Glass passivated rectifier diodes in hermetically sealed axial-leaded ID* envelopes and intended for general purpose rectifier applications.

The device is capable of absorbing reverse transient energy.

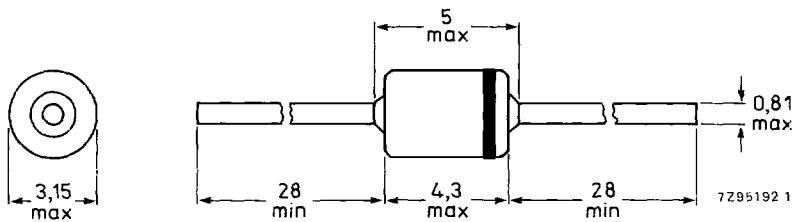
QUICK REFERENCE DATA

		BYD14D	G	J	K	M
Crest working voltage	V_{RWM} max.	200	400	600	800	1000 V
Reverse avalanche breakdown voltage	$V_{(BR)R} >$	225	450	650	900	1100 V
	$V_{(BR)R} <$	1600	1600	1600	1600	1600
Average forward current	$I_{F(AV)}$ max.	2			A	
Non-repetitive peak forward current	I_{FSM} max.	50			A	
Non-repetitive peak reverse avalanche energy	E_{RSM} max.	40			mJ	
Junction temperature	T_j max.	175			°C	

MECHANICAL DATA

Dimensions in mm

Fig. 1 SOD-84.



The marking band indicates the cathode.

* Implosion Diode.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134).

			BYD14D	G	J	K	M	
Crest working voltage	V_{RWM}	max.	200	400	600	800	1000	V
Continuous reverse voltage	V_R	max.	200	400	600	800	1000	V
Average forward current (averaged over any 20 ms period) $T_{tp} = 45\text{ }^\circ\text{C}$; lead length 10 mm $T_{amb} = 60\text{ }^\circ\text{C}$; see Fig. 2	$I_F(AV)$	max.			2			A
	$I_F(AV)$	max.			1			A
Repetitive peak forward current $T_{tp} = 45\text{ }^\circ\text{C}$; $f = 50\text{ Hz}$; $a = 4,5$ (inclusive derating for T_{jmax} at $V_{RRM} = 1000\text{ V}$)	I_{FRM}	max.			20			A
Non-repetitive peak forward current $t = 10\text{ ms}$, half-sinewave (see Fig. 10)	I_{FSM}	max.			50			A
Non-repetitive peak reverse avalanche energy; $I_R = 0,8\text{ A}$; $T_j = 25\text{ }^\circ\text{C}$ prior to surge; with inductive load switched off	E_{RSM}	max.			40			mJ
Storage temperature	T_{stg}			-65 to +175				$^\circ\text{C}$
Junction temperature	T_j	max.			175			$^\circ\text{C}$

THERMAL RESISTANCE

Influence of mounting method

1. Thermal resistance from junction to tie-point at a lead length of 10 mm
2. Thermal resistance from junction to ambient; device mounted on an 1,5 mm thick epoxy-glass printed circuit board; Cu-thickness $\geq 40\text{ }\mu\text{m}$; Fig. 2 (see "Thermal model")

$R_{th\ j-tp} =$		50	K/W
$R_{th\ j-a} =$		105	K/W

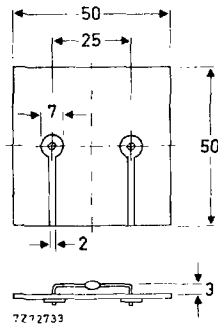


Fig. 2 Mounted on a printed-circuit board.

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified

		BYD14D	G	J	K	M
Forward voltage*						
$I_F = 3\text{ A}$	$V_F <$	1,15	1,15	1,15	1,15	1,15 V
$I_F = 3\text{ A}; T_j = T_{jmax}$	$V_F <$	1,05	1,05	1,05	1,05	1,05 V
Reverse avalanche breakdown voltage						
$I_R = 0,1\text{ mA}$	$V_{(BR)R} >$	225	450	650	900	1100 V
	$V_{(BR)R} <$	1600	1600	1600	1600	1600 V
Reverse current						
$V_R = V_{RWMmax}^{**}$	$I_R <$			1		μA
$V_R = V_{RWMmax}; T_j = 165\text{ }^\circ\text{C}$	$I_R <$			150		μA
Reverse recovery when switched from $I_F = 1\text{ A}$ to $V_R \geq 30\text{ V}$ with $-dI_F/dt = 5\text{ A}/\mu\text{s}$						
recovery charge	Q_S typ.			3		μC
recovery time	t_{rr} typ.			2,5		μs
Diode capacitance at $f = 1\text{ MHz}$ $V_R = 0$	C_d typ.			50		pF

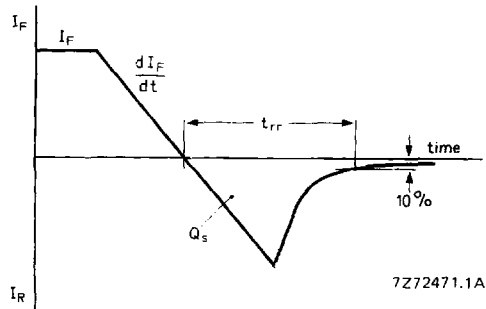


Fig. 3 Definitions of t_{rr} , Q_S and dI_F/dt .

* Measured under pulse conditions to avoid excessive dissipation.

** Illuminance $\leq 500\text{ lux}$ (daylight); relative humidity $< 65\%$.

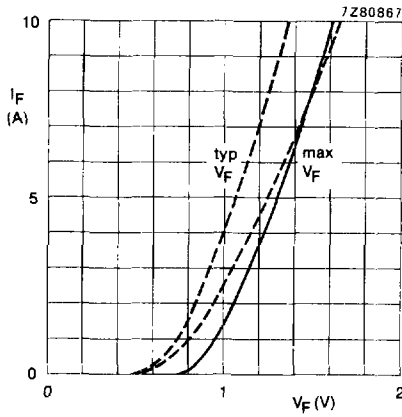


Fig. 4 Forward voltage;
 — $T_j = 25\text{ }^\circ\text{C}$; - - - $T_j = 175\text{ }^\circ\text{C}$.

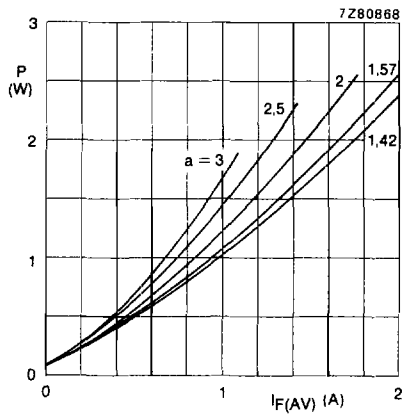


Fig. 5 Maximum values steady state power dissipation (forward plus leakage current) as a function of the average a forward current.
 $a = I_F(\text{RMS})/I_F(\text{AV})$; $V_R = V_{\text{RWMmax}}$.

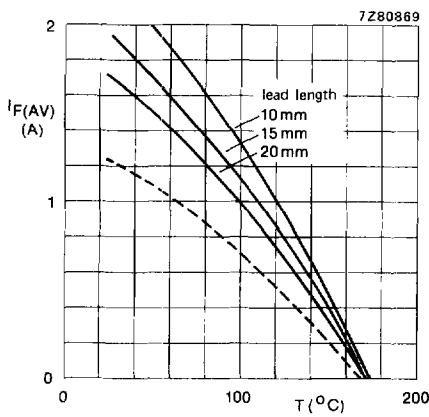


Fig. 6 Maximum average forward current as a function of temperature; the curves include losses due to reverse leakage.
 $V_R = V_{\text{RWMmax}}$, $\delta = 0,5$; $a = 1,57$.
 - - - = ambient temperature and device mounted as shown in Fig. 2
 — = tie-point temperature

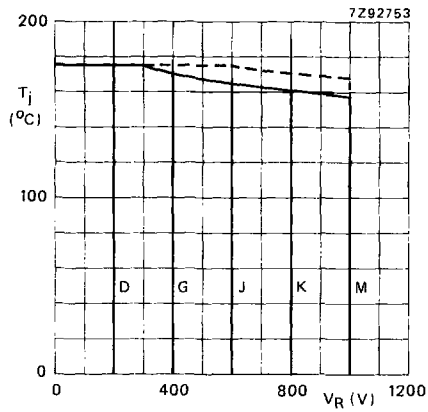


Fig. 7 Maximum permissible junction temperature as a function of reverse voltage; — = V_R ; - - - = V_{RWM} , $\delta = 0,5$, device mounted as shown in Fig. 2.

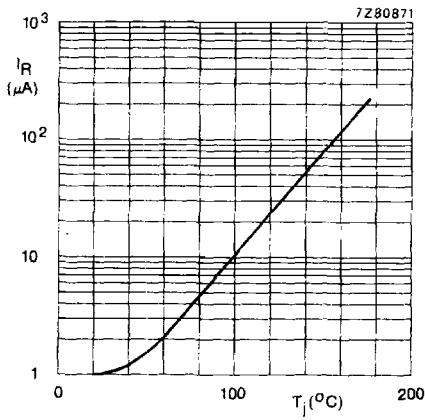


Fig. 8 Maximum values reverse current as a function of junction temperature; $V_R = V_{RWMmax}$.

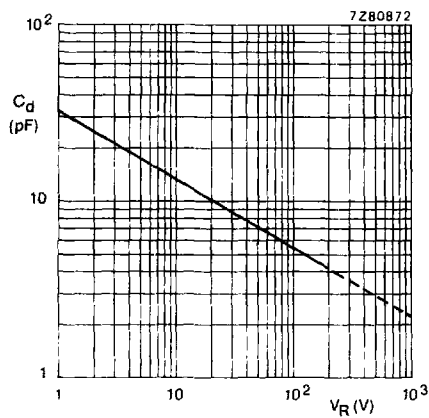


Fig. 9 Capacitance as a function of reverse voltage; $f = 1 \text{ MHz}$; $T_j = 25 \text{ }^\circ\text{C}$; typical values.

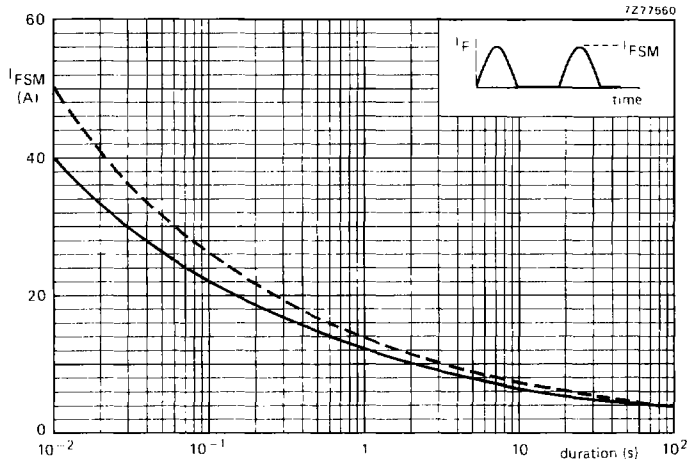


Fig. 10 Maximum permissible non-repetitive peak forward current based on sinusoidal currents; $f = 50$ Hz.

----- $T_j = 25$ °C prior to surge; $V_R = 0$
 ——— $T_j = T_j$ max prior to surge; $V_R = V_{RWM}$ max.

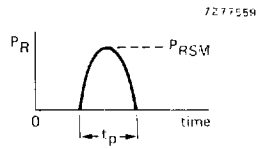
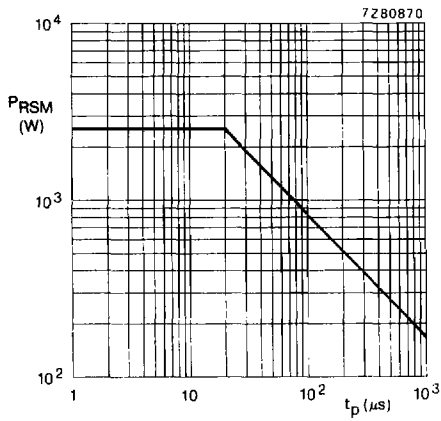


Fig. 11 Non-repetitive peak reverse power in the avalanche region; $T_j = 25$ °C prior to surge; typical values.